| $\mathbf{B V}_{\mathrm{DSX}}{ }^{\prime}$ <br> $\mathbf{B V}_{\mathrm{DGX}}$ | $\mathbf{R}_{\mathrm{DS}(\mathbf{O N})}$ <br> $(\mathbf{m a x})$ | $\mathrm{I}_{\mathrm{DSS}}(\mathbf{m i n})$ | Package |
| :---: | :---: | :---: | :---: |
| 250 V | $4 \Omega$ | 360 mA | SOT-89 |

## Features

- Depletion mode device offers low $\mathrm{R}_{\mathrm{DS}(\mathrm{ON})}$ at cold temperatures
- Low on resistance 4 ohms max. at $25^{\circ} \mathrm{C}$
- High input impedance
- High breakdown voltage 250 V
- Low $\mathrm{V}_{\mathrm{GS}(\text { off })}$ voltage -1.6 to -3.9 V
- Small package size SOT89


## Applications

- Ignition Modules
- Normally-on Switches
- Solid State Relays
- Converters
- Telecommunications
- Power Supply


## Package Pinout


(SOT89)

## Description

The CPC3703 is an N-channel, depletion mode, field effect transistor (FET) that utilizes Clare's proprietary third-generation vertical DMOS process. The third-generation process realizes world class, high voltage MOSFET performance in an economical silicon gate process. Our vertical DMOS process yields a robust device, with high input impedance, for use in high-power applications. The CPC3703 is a highly reliable FET device that has been used extensively in Clare's Solid State Relays for industrial and telecommunications applications.

This device excels in power applications that require low drain-source resistance, particularly in cold environments such as automotive ignition modules. The CPC 3703 offers a low, $4 \Omega$ maximum, on-state resistance at $25^{\circ} \mathrm{C}$.

The CPC3703 has a minimum breakdown voltage of 250 V , and is available in an SOT89 package. As with all MOS devices, the FET structure prevents thermal runaway and thermal-induced secondary breakdown.

Ordering Information

| Part \# | Description |
| :--- | :--- |
| CPC3703C | SOT89 (100/Tube) |
| CPC3703CTR | SOT89 (2000/Reel) |

Circuit Symbol



Absolute Maximum Ratings

| Parameter | Ratings | Units |
| :--- | :---: | :---: |
| Drain-to-Source Voltage | 250 | V |
| Gate-to-Source Voltage | $\pm 20$ | V |
| Total Package Dissipation ${ }^{1}$ | 1.6 | W |
| Operational Temperature | -55 to +125 | ${ }^{\circ} \mathrm{C}$ |
| Storage Temperature | -55 to +125 | ${ }^{\circ} \mathrm{C}$ |

Absolute Maximum Ratings are stress ratings. Stresses in excess of these ratings can cause permanent damage to the device. Functional operation of the device at conditions beyond those indicated in the operational sections of this data sheet is not implied.
${ }^{1}$ Mounted on 1"x1" FR4 board.

## Thermal Characteristics

| Package | $I_{D}$ (continuous) | $I_{D}$ (pulsed) | Power Dissipation <br> $@ T_{A}=25^{\circ} \mathbf{C}$ | $\theta_{j c}$ <br> ${ }^{\circ} \mathbf{C} / \mathbf{W}$ | $I_{D R}$ | $I_{D R M}$ |
| :--- | :---: | :---: | :---: | :---: | :---: | :---: |
| SOT-89 | 360 mA | 600 mA | 1.6 W | 15 | 360 mA | 600 mA |

## Electrical Characteristics

| Parameter | Symbol | Conditions | Min | Typ | Max | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Drain-to-Source Breakdown Voltage | BV ${ }_{\text {DSX }}$ | $\mathrm{V}_{\text {GS }}=-5 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=100 \mu \mathrm{~A}$ | 250 | - | - | V |
| Gate-to-Source Off Voltage | $\mathrm{V}_{\text {GS(off) }}$ | $\mathrm{V}_{\mathrm{DS}}=15 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=1 \mathrm{~mA}$ | -1.6 | - | -3.9 | V |
| Change in $\mathrm{V}_{\text {GS(off) }}$ with Temperature | $\mathrm{dV}_{\mathrm{GS}(\text { (ff) }} / \mathrm{dT}$ | $\mathrm{V}_{\text {DS }}=15 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=1 \mathrm{~mA}$ | - | - | 4.5 | $\mathrm{mV} /{ }^{\circ} \mathrm{C}$ |
| Gate Body Leakage Current | $\mathrm{I}_{\text {GSS }}$ | $\mathrm{V}_{\mathrm{GS}}= \pm 20 \mathrm{~V}, \mathrm{~V}_{\text {DS }}=0 \mathrm{~V}$ | - | - | 100 | nA |
| Drain-to-Source Leakage Current | $\mathrm{I}_{\mathrm{D} \text { (off) }}$ | $\mathrm{V}_{G S}=-5 \mathrm{~V}, \mathrm{~V}_{\text {DS }}=$ Max Rating | - | - | 1 | $\mu \mathrm{A}$ |
|  |  | $V_{G S}=-5 \mathrm{~V}, \mathrm{~V}_{\mathrm{DS}}=200 \mathrm{~V}, \mathrm{~T}_{A}=125^{\circ} \mathrm{C}$ | - | - | 1 | mA |
| Saturated Drain-to-Source Current | $\mathrm{I}_{\text {DSS }}$ | $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{DS}}=15 \mathrm{~V}$ | 300 | - | - | mA |
| Static Drain-to-Source On-State Resistance | $\mathrm{R}_{\mathrm{DS} \text { (on) }}$ | $V_{G S}=0 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=200 \mathrm{~mA}$ | - | - | 4 | $\Omega$ |
| Change in $\mathrm{R}_{\mathrm{DS}(\text { on) }}$ with Temperature | $\mathrm{dR}_{\text {DS(on) }} / \mathrm{dT}$ |  | - | - | 1.1 | $\% /{ }^{\circ} \mathrm{C}$ |
| Forward Transconductance | $\mathrm{G}_{\text {FS }}$ | $\mathrm{I}_{\mathrm{D}}=100 \mathrm{~mA}, \mathrm{~V}_{\text {DS }}=10 \mathrm{~V}$ | 225 | - | - | m |
| Input Capacitance | $\mathrm{C}_{\text {ISS }}$ | $\begin{gathered} V_{G S}=-5 \mathrm{~V} \\ V_{D S}=25 \mathrm{~V} \\ f=1 \mathrm{MHz} \end{gathered}$ | - | 327 | 350 | pF |
| Common Source Output Capacitance | $\mathrm{C}_{\text {oss }}$ |  |  | 51 | 65 |  |
| Reverse Transfer Capacitance | $\mathrm{C}_{\text {RSS }}$ |  |  | 27 | 35 |  |
| Turn-ON Delay Time | $\mathrm{t}_{\mathrm{d}(0 n)}$ | $\begin{gathered} \mathrm{I}_{\mathrm{D}}=150 \mathrm{~mA} \\ \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V} \text { to }-10 \mathrm{~V} \\ \mathrm{R}_{\mathrm{GEN}}=50 \Omega \end{gathered}$ | - | 23 | 35 | ns |
| Rise Time | $\mathrm{t}_{\mathrm{r}}$ |  |  | 8 | 20 |  |
| Turn-OFF Delay Time | $\mathrm{t}_{\text {d(off) }}$ |  |  | 17 | 25 |  |
| Fall Time | $\mathrm{t}_{\mathrm{f}}$ |  |  | 70 | 80 |  |
| Source-Drain Diode Voltage Drop | $\mathrm{V}_{\text {SD }}$ | $\mathrm{V}_{G S}=-5 \mathrm{~V}, \mathrm{I}_{\text {SD }}=150 \mathrm{~mA}$ | - | 0.6 | 1.8 | V |

## Switching Waveform \& Test Circuit



## PERFORMANCE DATA*




*The Performance data shown in the graphs above is typical of device performance. For guaranteed parameters not indicated in the written specifications, please contact our application department.

## Manufacturing Information

## Soldering

For proper assembly, the component must be processed in accordance with the current revision of IPC/JEDEC standard J-STD-020. Failure to follow the recommended guidelines may cause permanent damage to the device resulting in impaired performance and/or a reduced lifetime expectancy.

## Washing

Clare does not recommend ultrasonic cleaning or the use of chlorinated solvents.


## MECHANICAL DIMENSIONS



Tape and Reel Packaging for SOT89 Package


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